Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	-
10/501,672	TAKENO, HIROSHI	
Examiner	Art Unit	

Felisa C. Hiteshew

SEARCHED						
Class	Subclass	Date	Examiner			
117	89	7/24/2006	F.H.			
117	92	7/24/2006	F.H.			
117	93	7/24/2006	F.H.			
117	95	7/24/2006	F.H.			
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
STN (hcaplus, inspec, japio, uspatall, inpadoc)	7/24/2006	F.H.		
Inventor's Name Search	7/24/2006	F.H.		